SCCS045A - MAY 1994 - REVISED SEPTEMBER 2001

- Function and Pinout Compatible With FCT, F, and AM29827 Logic
- 25-Ω Output Series Resistors Reduce Transmission-Line Reflection Noise
- Reduced V_{OH} (Typically = 3.3 V) Versions of Equivalent FCT Functions
- Edge-Rate Control Circuitry for Significantly Improved Noise Characteristics
- I_{off} Supports Partial-Power-Down Mode Operation
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- Matched Rise and Fall Times
- Fully Compatible With TTL Input and Output Logic Levels
- 12-mA Output Sink Current
 15-mA Output Source Current
- 3-State Outputs

OE₁ [24 🛮 V_{CC} 23 TY₀ $D_0 \square 2$ 22 X1 D₂ [] 4 21 X2 20 **[**] Y₃ $D_3 \square 5$ D₄ [] 6 19 ∐Y₄ 18 **[**] Y₅ D₅ [] 7 17 🛮 Y₆ D₆ [] 8 D₇ [] 9 16 | Y₇ 15 🛮 Y₈ D₈ [] 10 14 🛮 Y₉ D₉ [] 11 13 ∏ŌE₂ GND [] 12

Q PACKAGE (TOP VIEW)

description

The CY74FCT2827T 10-bit buffer provides high-performance bus-interface buffering for wide data/address paths or buses carrying parity. This 10-bit buffer has NANDed output-enable (\overline{OE}) inputs for maximum control flexibility. The CY74FCT2827T is designed for high-capacitance-load drive capability, while providing low-capacitance bus loading at both inputs and outputs. All inputs have clamp diodes and all outputs are designed for low-capacitance bus loading in the high-impedance state. On-chip termination resistors at the outputs reduce system noise caused by reflections. The CY74FCT2827T can replace the CY74FCT827T to reduce noise in an existing design.

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

ORDERING INFORMATION

TA	PACKAGE [†]		SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE MARKING
–40°C to 85°C	QSOP - Q	Tape and reel	4.4	CY74FCT2827CTQCT	FCT2827C
-40 C 10 65 C	QSOP - Q	Tape and reel	8	CY74FCT2827ATQCT	FCT2827A

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

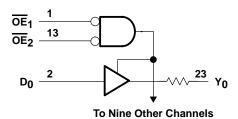


FUNCTION TABLE

	INPUTS		OUTPUT	FUNCTION
OE ₁	OE ₂	D	Y	FUNCTION
L	L	L	L	Transparent
L	L	Н	Н	Transparent
Н	Х	Х	Z	2 State
Х	Н	Χ	Z	3-State

H = High logic level, L = Low logic level, X = Don't care, Z = High-impedance state

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range to ground potential	0.5 V to 7 V
DC input voltage range	-0.5 V to 7 V
DC output voltage range	$-0.5\ V$ to $7\ V$
DC output current (maximum sink current/pin)	120 mA
Package thermal impedance, θ _{JA} (see Note 1)	61°C/W
Ambient temperature range with power applied, T _A	-65°C to 135°C
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 2)

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.75	5	5.25	V
VIH	High-level input voltage	2		, and the second	V
٧ _{IL}	Low-level input voltage			0.8	V
loh	High-level output current			-15	mA
loL	Low-level output current			12	mA
T _A	Operating free-air temperature	-40		85	°C

NOTE 2: All unused inputs of the device must be held at VCC or GND to ensure proper device operation.



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITION	IS	MIN	TYP†	MAX	UNIT
VIK	$V_{CC} = 4.75,$	I _{IN} = -18 mA			-0.7	-1.2	V
VOH	$V_{CC} = 4.75,$	I _{OH} = -15 mA		2.4	3.3		V
VOL	V _{CC} = 4.75,	I _{OL} = 12 mA			0.3	0.55	V
R _{out}	$V_{CC} = 4.75,$	I _{OL} = 12 mA		20	25	40	Ω
V_{hys}	All inputs				0.2		V
lį	V _{CC} = 5.25 V,	$V_{IN} = V_{CC}$				5	μΑ
lін	V _{CC} = 5.25 V,	V _{IN} = 2.7 V				±1	μΑ
l _{IL}	$V_{CC} = 5.25 \text{ V},$	V _{IN} = 0.5 V				±1	μΑ
los [‡]	V _{CC} = 5.25 V,	V _{OUT} = 0 V		-60	-120	-225	mA
l _{off}	$V_{CC} = 0 V$	V _{OUT} = 4.5 V				±1	μΑ
lozh	V _{CC} = 5.25 V,	V _{OUT} = 2.7 V				10	μΑ
lozl	$V_{CC} = 5.25 \text{ V},$	V _{OUT} = 0.5 V				-10	μΑ
lcc	$V_{CC} = 5.25 \text{ V},$	$V_{IN} \le 0.2 V$,	$V_{IN} \ge V_{CC} - 0.2 V$		0.1	0.2	mA
Δ ICC	$V_{CC} = 5.25 \text{ V}, V_{IN} = 3$	3.4 V , $f_1 = 0$, Outputs of	ppen		0.5	2	mA
^I CCD [¶]		put switching at 50% du $V_{IN} \le 0.2 \text{ V or } V_{IN} \ge V_{C}$			0.06	0.12	mA/ MHz
		One bit switching at f ₁ = 10 MHz	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$		0.7	1.4	
lc#	V _{CC} = 5.25 V,	at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		1	2.4	mA
ıC.,	Outputs open, OE ₁ or OE ₂ = GND	Ten bits switching at f ₁ = 2.5 MHz	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$		1.6	3.2	IIIA
		at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		4.1	13.2	
C _i					5	10	pF
Co					9	12	pF

[†] Typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

I_C = Total supply current

ICC = Power-supply current with CMOS input levels

 ΔI_{CC} = Power-supply current for a TTL high input ($V_{IN} = 3.4 \text{ V}$)

D_H = Duty cycle for TTL inputs high N_T = Number of TTL inputs at D_H

I_{CCD} = Dynamic current caused by an input transition pair (HLH or LHL)

f₀ = Clock frequency for registered devices, otherwise zero

f₁ = Input signal frequency

N₁ = Number of inputs changing at f₁

All currents are in milliamperes and all frequencies are in megahertz.

 \parallel Values for these conditions are examples of the $I_{\hbox{\footnotesize CC}}$ formula.



Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, Ins tests should be performed last.

[§] Per TTL-driven input (V_{IN} = 3.4 V); all other inputs at V_{CC} or GND

 $[\]P$ This parameter is derived for use in total power-supply calculations.

[#] I_C = I_{CC} + Δ I_{CC} × D_H × N_T + I_{CCD} (f₀/2 + f₁ × N₁) Where:

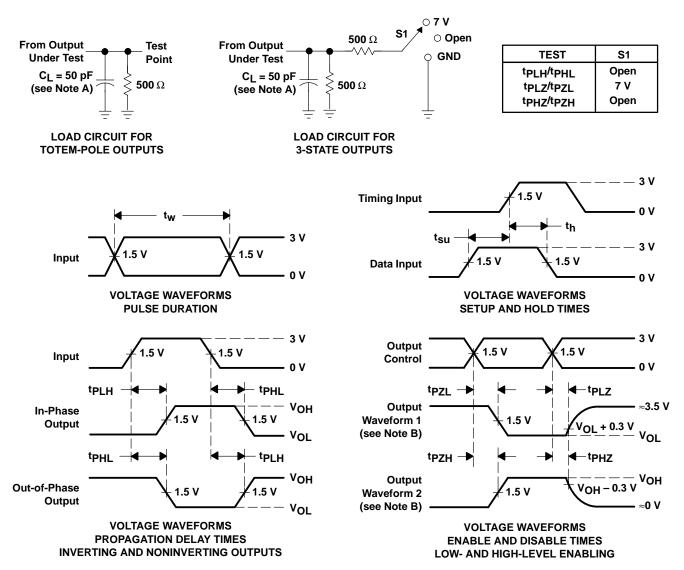
CY74FCT2827T 10-BIT BUFFER WITH 3-STATE OUTPUTS SCCS045A - MAY 1994 - REVISED SEPTEMBER 2001

switching characteristics over operating free-air temperature range (see Figure 1)

PARAMETER	FROM	то	TEST LOAD	CY74FCT	2827AT	CY74FCT	2827CT	UNIT
PARAMETER	(INPUT)	(OUTPUT)		MIN	MAX	MIN	MAX	UNIT
^t PLH	D	Y	$C_L = 50 \text{ pF},$	1.5	8	1.5	4.4	ns
^t PHL		$R_L = 500 \Omega$	1.5	8	1.5	4.4	115	
^t PLH	D	V	$C_L = 300 pF$,	1.5	15	1.5	10	ns
^t PHL	D	ľ	$R_L = 500 \Omega$	1.5	15	1.5	10	115
^t PZH	ŌĒ	Y	$C_L = 50 pF$,	1.5	12	1.5	7	ns
^t PZL	OL	R _L = 50	$R_L = 500 \Omega$	1.5	12	1.5	7	115
^t PZH	ŌĒ	Y	$C_L = 300 pF$,	1.5	23	1.5	14	ns
^t PZL	OE .	ľ	$R_L = 500 \Omega$	1.5	23	1.5	14	115
^t PHZ	ŌĒ	Y	$C_L = 5 pF$,	1.5	9	1.5	5.7	ns
^t PLZ		r	$R_L = 500 \Omega$	1.5	9	1.5	5.7	115
^t PHZ	ŌĒ	Y	$C_L = 50 \text{ pF},$	1.5	9	1.5	6	ns
^t PLZ	UE		$R_L = 500 \Omega$	1.5	9	1.5	6	115



PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms





16-Aug-2012

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
CY74FCT2827ATQCT	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
CY74FCT2827ATQCTE4	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
CY74FCT2827ATQCTG4	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
CY74FCT2827CTQCT	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
CY74FCT2827CTQCTE4	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
CY74FCT2827CTQCTG4	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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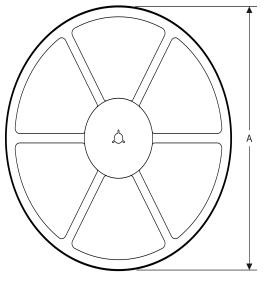
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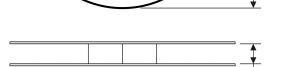
PACKAGE MATERIALS INFORMATION

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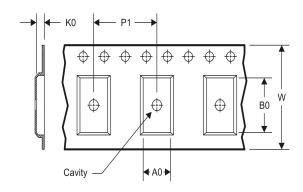
TAPE AND REEL INFORMATION

REEL DIMENSIONS





TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CY74FCT2827ATQCT	SSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CY74FCT2827CTQCT	SSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1

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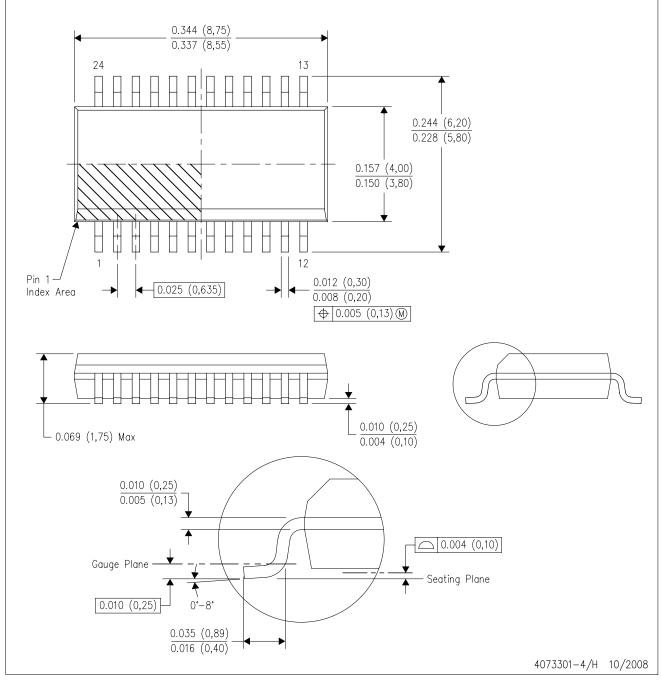


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CY74FCT2827ATQCT	SSOP	DBQ	24	2500	367.0	367.0	38.0
CY74FCT2827CTQCT	SSOP	DBQ	24	2500	367.0	367.0	38.0

DBQ (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



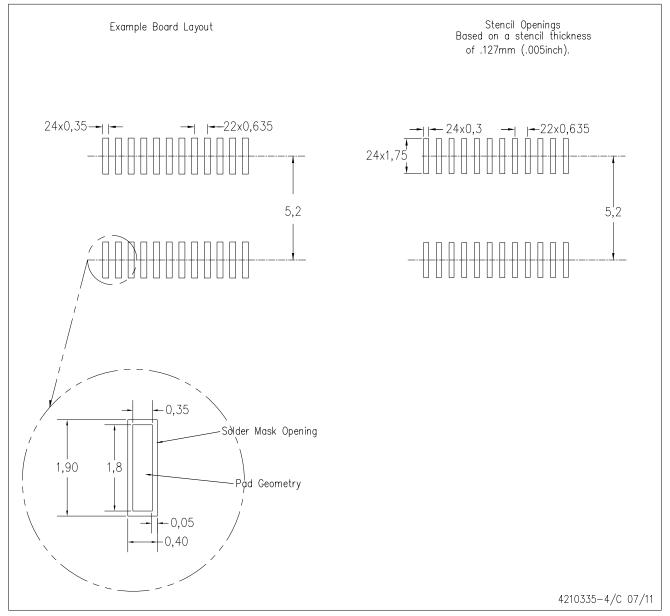
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
- D. Falls within JEDEC MO-137 variation AE.



DBQ (R-PDSO-G24)

PLASTIC SMALL OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



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